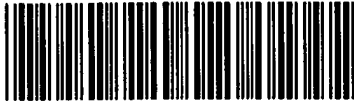


Search Notes

Application/Control No.

10/764,321

Examiner

Thomas D. Lee

Applicant(s)/Patent under
Reexamination

CHANG, CHING-WEI

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
358	3.03, 3.04, 3.05, 1.9	1/31/2008	TDL
382	252, 253	1/31/2008	TDL
382	251	1/31/2008	TDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search History Printout	1/31/2008	TDL